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_	Application/Control No.	Applicant(s)/Patent under Reexamination	i
	10/773,238	NOGUCHI ET AL.	1.
	Examiner	Art Unit	1
	Kenneth J. Malkowski	2613	

	SEAR	CHED	
Class	Subclass	Date	Examiner
398	82	2/14/2007	KJM
398	85	2/14/2007	КЈМ
359	305	2/14/2007	KJM
359	307	2/14/2007	KJM
359	308	2/14/2007	KJM

INTERFERENCE SEARCHED						
Class	Subclass	Date	Examiner			

SEARCH (INCLUDING SEAF		)
	DATE	EXMR
text search	2/14/2007	KJM
text search in class 398	2/14/2007	KJM
IEEE text search	2/14/2007	KJM
IEEE author search	2/14/2007	KJM
author search	2/14/2007	KJM
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